Application/Control No. Applicant(s)/Patent Under Reexamination 10/768,166 WU ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Kin-Chan Chen 1765 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY * Α US-2004/0110370 06-2004 Okayama et al. 438/638 * US-6,440,842 08-2002 Chang, Ching-Yu В 438/633 US-6,455,436 09-2002 Ueda et al. С 438/706 * US-6,787,448 09-2004 Chung, Jin-Sung 438/624 D US-6,924,228 08-2005 Kim et al. Ε 438/636 * F US-2003/0170978 09-2003 Lee, Shyh-Dar 438/638 * US-2002/0177301 11-2002 Biolsi et al. G 438/637 * US-6,642,138 11-2003 438/619 Pan et al. Н US-1 US-J Κ US-US-L US-M FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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